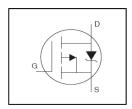


AUTOMOTIVE GRADE

AUIRF6215S

Features

- Advanced Planar Technology
- Low On-Resistance
- P-Channel MOSFET
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- · Fully Avalanche Rated
- · Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



HEXF	ET [®] Power MOSFET
V _{DSS}	-150V
R _{DS(on)} max.	0.29Ω
I _D	-13A



G	D	S
Gate	Drain	Source

Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

Base part number	Dookogo Typo	Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
ALUDEGO4EC	D ² Dok	Tube	50	AUIRF6215S
AUIRF6215S D ² -Pak		Tape and Reel Left	800	AUIRF6215STRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10V	-13	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ -10V	-9.0	Α
I _{DM}	Pulsed Drain Current ①	-44	
P _D @T _A = 25°C	Maximum Power Dissipation	3.8	10/
P _D @T _C = 25°C	Maximum Power Dissipation	110	W
	Linear Derating Factor	0.71	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	310	mJ
I _{AR}	Avalanche Current ①	-6.6	А
E _{AR}	Repetitive Avalanche Energy ①	11	mJ
dv/dt	Peak Diode Recovery ③	-5.0	V/ns
T_J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case®		1.4	°CAM
$R_{ heta JA}$	Junction-to-Ambient (PCB Mount, steady state) ©		40	°C/W

HEXFET® is a registered trademark of Infineon.

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-150			V	$V_{GS} = 0V, I_{D} = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.20		V/°C	Reference to 25 $^{\circ}$ C, I_D = -1mA
D	Static Drain-to-Source On-Resistance			0.29		$V_{GS} = -10V, I_D = -6.6A \oplus$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance			0.58	Ω	$V_{GS} = -10V, I_D = -6.6A, T_J = 150^{\circ}C$ ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
g _{fs}	Forward Trans conductance	3.6			S	$V_{DS} = -25V, I_{D} = -6.6A$
	Drain-to-Source Leakage Current			-25		$V_{DS} = -150V, V_{GS} = 0V$
IDSS	Dialii-10-30urce Leakage Current			-250	μΑ	$V_{DS} = -120V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I_{GSS}	Gate-to-Source Forward Leakage			-100		$V_{GS} = -20V$
	Gate-to-Source Reverse Leakage			100	nA	V _{GS} = 20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q _q	Total Gate Charge	 	66		I _D = -6.6A
Q_{gs}	Gate-to-Source Charge	 	8.1	nC	V _{DS} = -120V
Q_{gd}	Gate-to-Drain Charge		35		V _{GS} = -10V@
$t_{d(on)}$	Turn-On Delay Time	 14			$V_{DD} = -75V$
t _r	Rise Time	 36		no	$I_D = -6.6A$
$t_{d(off)}$	Turn-Off Delay Time	 53		ns	$R_G = 6.8\Omega$,
t _f	Fall Time	 37			R _D = 12Ω ④
L _S	Internal Source Inductance	 7.5		nΗ	Between lead,6mm (0.25in.) from package and center of die contact
C _{iss}	Input Capacitance	 860			V _{GS} = 0V
Coss	Output Capacitance	 220		рF	$V_{DS} = -25V$
C _{rss}	Reverse Transfer Capacitance	 130			f = 1.0MHz, See Fig.5

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			-11		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			-44		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			-1.6	V	$T_J = 25^{\circ}C, I_S = -6.6A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		160	240	ns	$T_J = 25^{\circ}C$, $I_F = -6.6A$
Q_{rr}	Reverse Recovery Charge		1.2	1.7	μC	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsi	c turn-c	on time	is neglig	ible (turn-on is dominated by L _S +L _D)

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)
- ② Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 14mH, $R_G = 25\Omega$, $I_{AS} = -6.6 Å$. (See fig.12)
- $\label{eq:loss_spectrum} \mbox{ } \m$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

® R_θ is measured at T_J of approximately 90°C

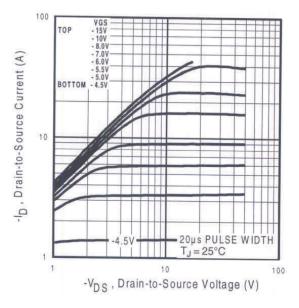


Fig. 1 Typical Output Characteristics

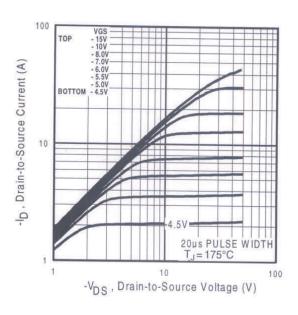


Fig. 2 Typical Output Characteristics

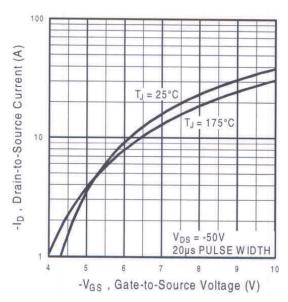


Fig. 3 Typical Transfer Characteristics

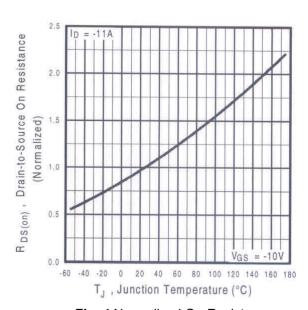


Fig. 4 Normalized On-Resistance vs. Temperature

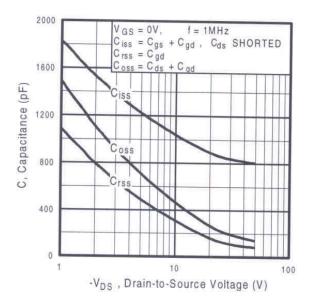


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

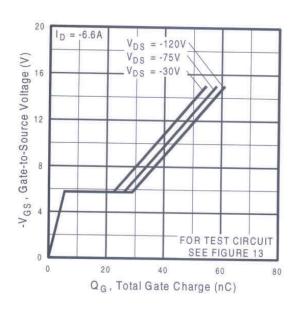


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

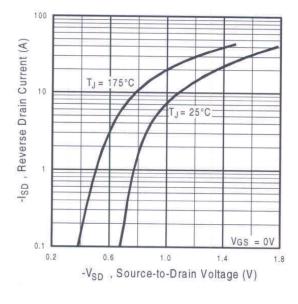


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

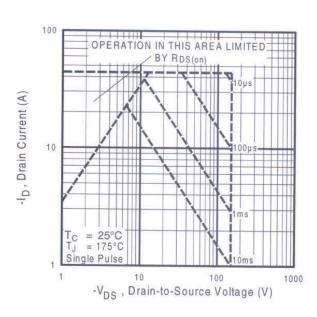


Fig 8. Maximum Safe Operating Area

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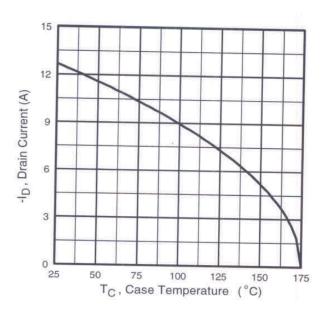


Fig 9. Maximum Drain Current vs. Case Temperature

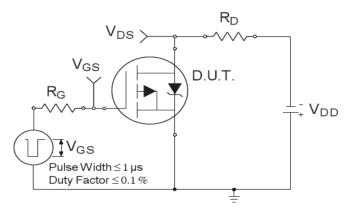


Fig 10a. Switching Time Test Circuit

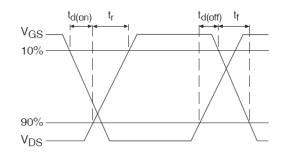


Fig 10b. Switching Time Waveforms

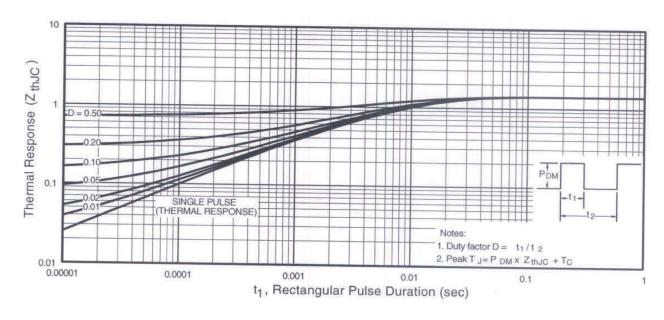


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



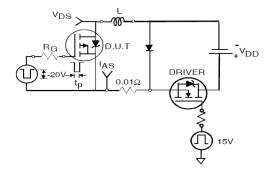


Fig 12a. Unclamped Inductive Test Circuit

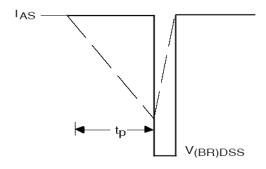


Fig 12b. Unclamped Inductive Waveforms

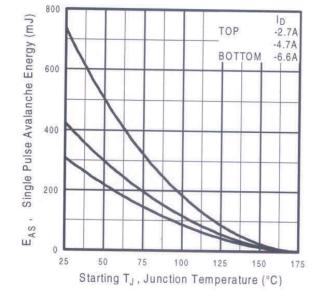
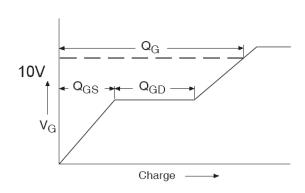


Fig 12c. Maximum Avalanche Energy vs. Drain Current



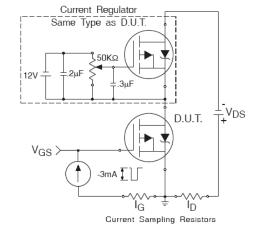
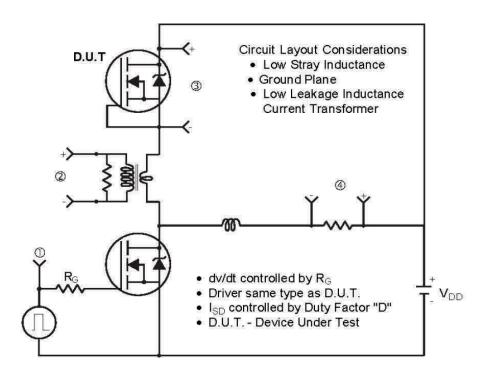


Fig 13b. Gate Charge Test Circuit

Fig 13a. Gate Charge Waveform



Peak Diode Recovery dv/dt Test Circuit



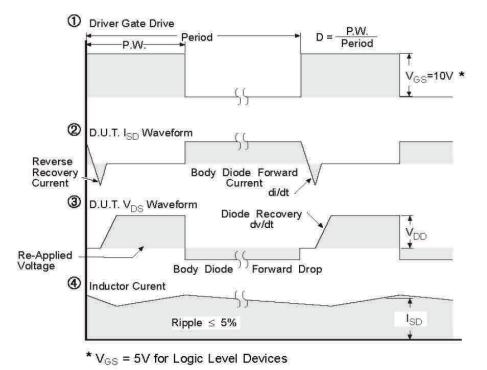
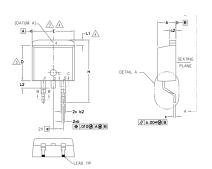
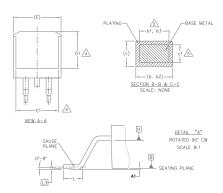


Fig 14. Peak Diode Recovery dv/dt Test Circuit for P-Channel HEXFET® Power MOSFETs



D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





MA	т	г		٠
NO	1	L	J	٠.

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S			N		
M B	MILLIMETERS			HES	O T E S
0 L	MIN.	MAX.	MIN.	MAX.	S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	_	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	_	.066	4
L2	_	1.78	_	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

DIODES

1.— ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.— CATHODE 3.— ANODE

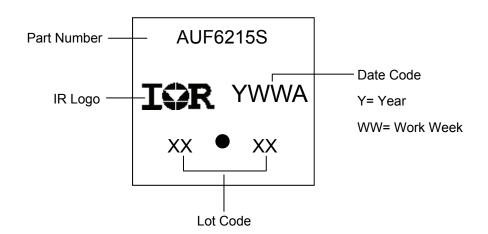
HEXFET

IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE

1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

D²Pak (TO-263AB) Part Marking Information

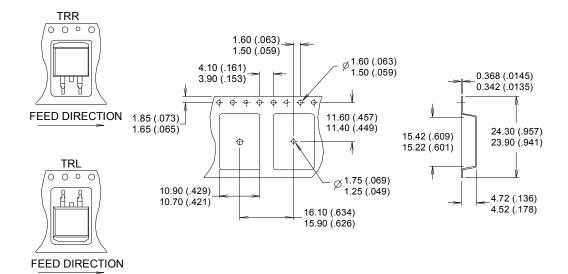


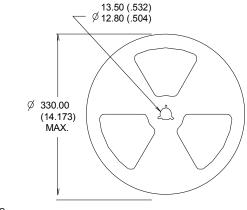
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

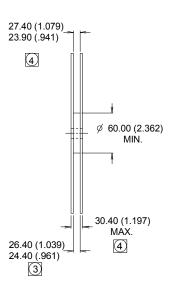
2015-11-13



D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







NOTES:

- 1. COMFORMS TO EIA-418.
- CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

2015-11-13



Qualification Information

		Automotive					
		(per AEC-Q101)					
Qualificat	ion Level	Comments: This part number(s) passed Automotive qualification. Infineon' Industrial and Consumer qualification level is granted by extension of the higher Automotive level.					
Moisture	Sensitivity Level	D ² -Pak MSL1					
		Class M3 (+/- 400V) [†]					
	Machine Model	AEC-Q101-002					
ESD	Human Rody Model		Class H1B (+/- 1000V) [†]				
EOD	ESD Human Body Model		AEC-Q101-001				
Charged Davies Madel		Class C5 (+/- 1125V) [†]					
	Charged Device Model AEC-Q101-005						
RoHS Co	mpliant	Yes					

[†] Highest passing voltage.

Revision History

Date	Comments		
11/13/2015	Updated datasheet with corporate template		
	Corrected ordering table on page 1.		

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